

# 承 認 書 SPECIFICATION FOR APPROVAL

客戶名稱 CUSTOMER	:			
客戶料號 CUSTOMER'S P/N	:			
料號 PART NUMBER	: <u>WAN3216F2</u>	45L08		
規格 DESCRIPTION	: Chip Antenna 3	216 L Ant 2.45G	Type 08	
版本 VERSION	: <u>V4.3</u>			
日期 ISSUE DATE	2023/06/16		KS,	
		X		
	客户承認 CUSTOMER APPROVED			
4	20			
	工程部 R&D CENTER			
CIT!	承 認 APPROVAL	確 認 CHECKED	製 作 DRAWN	
	Ray	Tennyson	Snow	





# 萬誠科技股份有限公司

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## OneWave Electronic Co., Ltd.

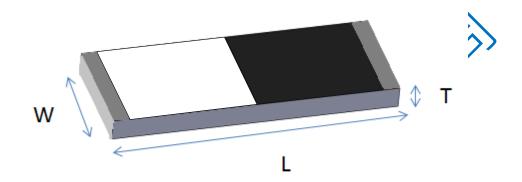
1F, No. 151, Li Gong Street, Beitou District, Taipei City 11261, Taiwan

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# 3216 Chip antenna

# For Bluetooth / WLAN Applications



P/N: WAN3216F245L08

		Dimension (mm)
10	L	3.23 ± 0.20
	W	1.66 ± 0.20
	Т	0.45 ± 0.20



#### **Part Number Information**

WAN 3216 F 245 L 08
A B C D E F

Λ	Draduct Carios	Antonno		
Α	Product Series	Antenna		
В	Dimension L x W	3.2 x 1.6mm (±0.2mm)		
C	Material	High K material		
D	Working Frequency	2.4 ~ 2.5GHz		
E	Feeding mode	Loop & Single Feeding		
F	Antenna type	Type = 08		

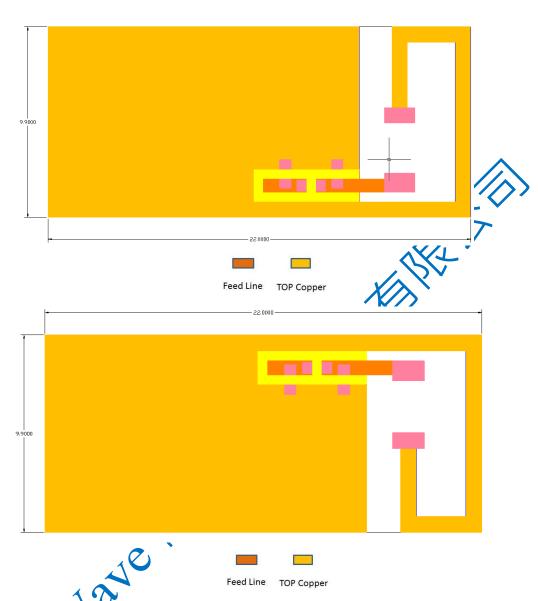
# 1. Electrical Specification

Specification			
Part Number	WAN3216F245L08		
Central Frequency	2450	MHz	
Bandwidth	110 (Min.)	MHz	
Return Loss	-10 (Max)	dB	
Peak Gam	1.15	dBi	
Impedance	50	Ohm	
Operating Temperature	-40~+110	$^{\circ}$ C	
Maximum Power	4	W	
Resistance to Soldering Heats	10 ( @ 260°C )	sec.	
Polarization	Linear		
Azimuth Beamwidth	Omni-directional		
Termination	Cu / Sn (Leadless)		

Remark : Bandwidth & Peak Gain was measured under evaluation board of next page



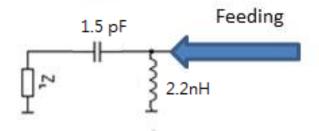
## 2. Recommended PCB Pattern Evaluation Board Dimension



## Suggested Matching Circuit

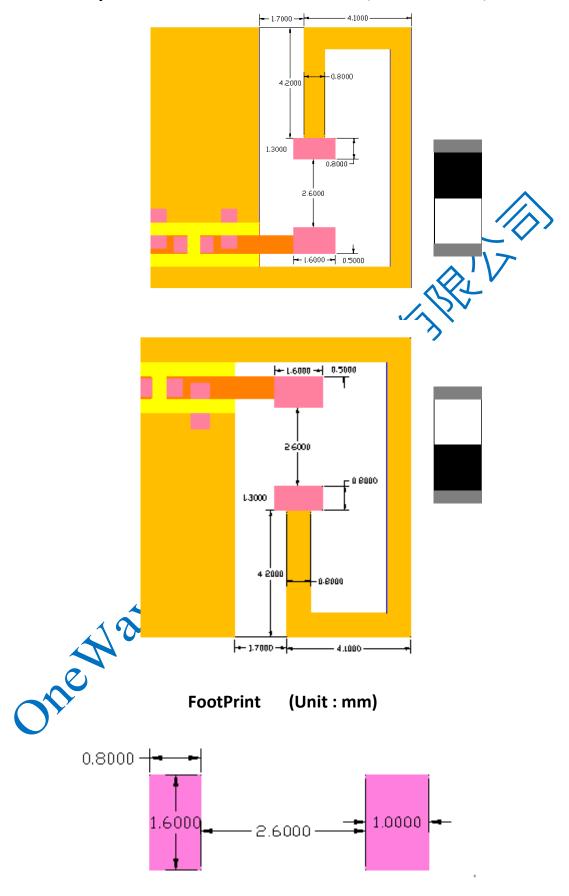
重要資訊

匹配不停建議使用精準度高的電感±0.1~0.3nH、電容±0.1pF



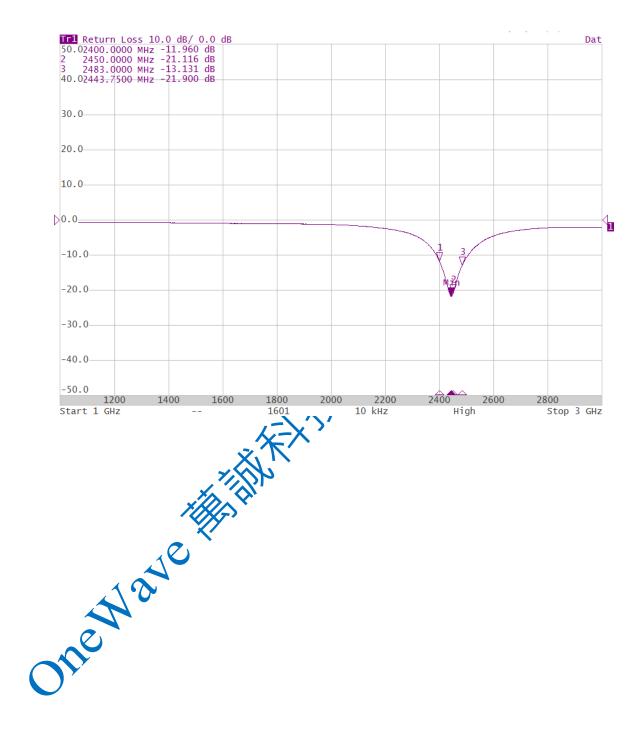


#### Layout Dimensions in Clearance area( Size=5.8\*9.9mm)



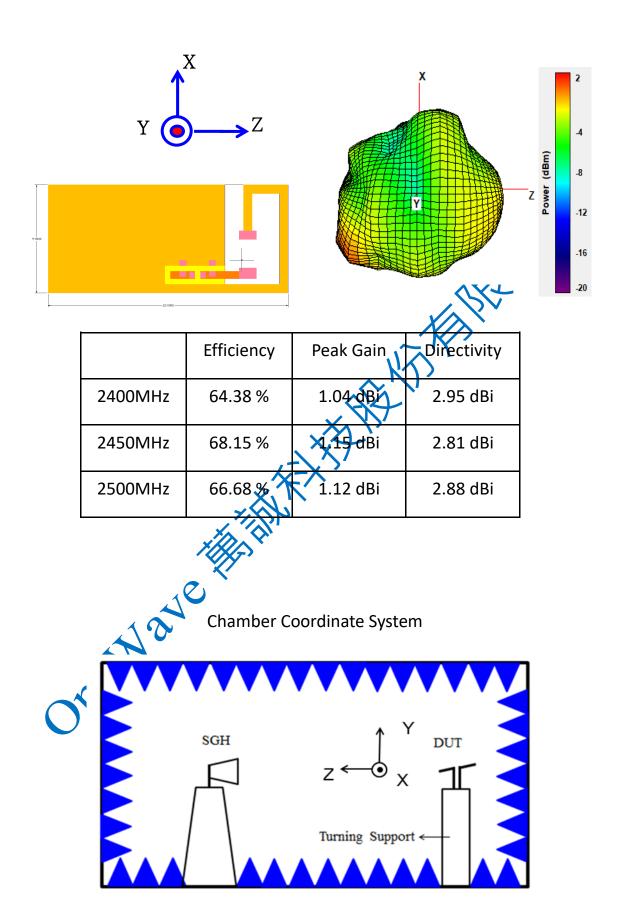


# 3. Measurement Results Return Loss





#### **Radiation Pattern**





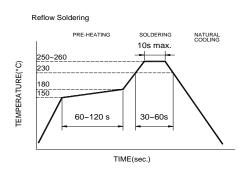
**4.Reliability and Test Condictions** 

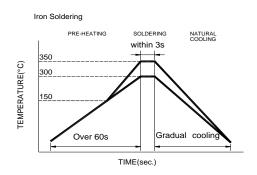
ITEM	REQUIREMENTS	TEST CONDITION
Solderability	Wetting shall exceed 90% coverage     New initial manager and demonstrations.	Pre-heating temperature:150°C/60sec.
	No visible mechanical damage	Solder temperature:230±5°C
	TEMP (℃)	Duration:4±1sec.
		Solder:Sn-Ag3.0-Cu0.5 Flux for lead free: rosin
	230°C 4±1 sec.	Flux for lead free. rosin
	/ \	
	150°C	
	60sec	
Solder heat	No visible mechanical damage	Pre-heating temperature:150°C/60sec.
Resistance	2. Central Freq. change :within ± 6%	Solder temperature:260±5℃
	TEMP (°C)	Duration:10±0.5sec.
	10+0.5.000	Solder:Sn-Ag3.0-Cu0.5
	260°C 10 <u>14.</u> 3 sec.	Flux for lead free: rosin
	150°C	
	130 C	N/L
	60sec	150
Component	No visible mechanical damage	The device should be reflow
Adhesion (Push test)		soldered(230±5°C for 10sec.) to a tinned
(	_	copper substrate A dynometer force gauge should be applied the side of the
		component. The device must with-ST-F
		0.5 Kg without failure of the termination
	X	attached to component.
Component	No visible mechanical damage	Insert 10cm wire into the remaining open
Adhesion	\_\	eye bend ,the ends of even wire lengths
(Pull test)	\ <u>\</u> -X'	upward and wind together.
	Ž, N	Terminal shall not be remarkably
Thermal shock	No visible mechanical damage	damaged. +110°C=>30±3min
THEITHAI SHOCK		-40°C =>30±3min
	2. Central Freq. change :within ±6%	Test cycle:10 cycles
	Phase Temperature(°C) Time(min)	The chip shall be stabilized at normal
	1 +110±5°C 30±3	condition for 2~3 hours before
	2 Room Within	measuring.
	Temperature 3sec	
	3 -40±2°C 30±3	
	Room Within	
	Temperature 3sec	
Resistance to	1. No visible mechanical damage	Temperature:+110±5°C
High	2. Central Freq. change :within ±6%	Duration: 1000±12hrs
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal
	3. No disconnection of short circuit.	condition for 2~3 hours before
		measuring.
Resistance to	No visible mechanical damage	Temperature:-40±5°C
Low	2. Central Freq. change :within ±6%	Duration: 1000±12hrs
Temperature	3. No disconnection or short circuit.	The chip shall be stabilized at normal
		condition for 2~3 hours before
L le mai alite e	A No. Citto and a city to	measuring.  Temperature: 40±2°C
Humidity	No visible mechanical damage	1
	2. Central Freq. change :within ±6%	Humidity: 90% to 95% RH Duration: 1000±12hrs
	3. No disconnection or short circuit.	The chip shall be stabilized at normal
		condition for 2~3 hours before
		measuring.
	<u> </u>	mododing.



#### 5. Soldering and Mounting

Mildly activated rosin fluxes are preferred. The minimum amount of solder can lead to damage from the stresses caused by the difference in coefficients of expansion between solder, chip and substrate. The terminations are suitable for all wave and re-flow soldering systems. If hand soldering cannot be avoided, the preferred technique is the utilization of hot air soldering tools.





Recommended temperature profiles for re-flow soldering in Figure 1.

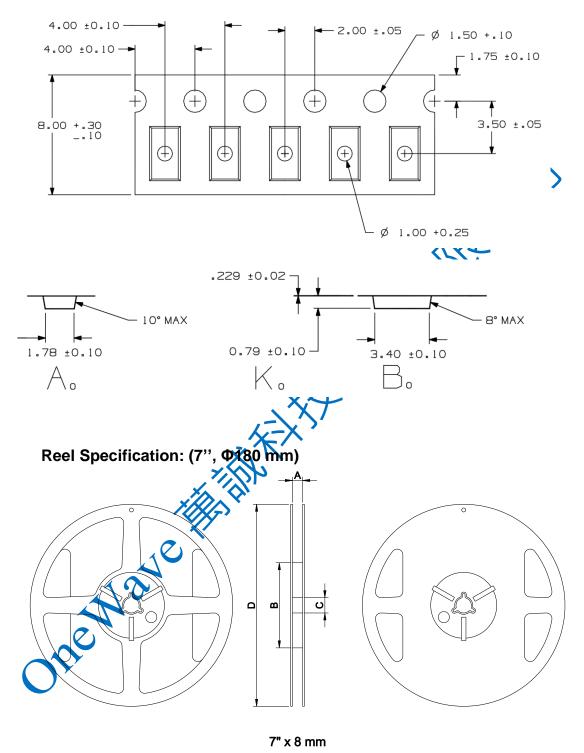
Products attachment with a soldering iron is discouraged due to the inherent process control limitations. In the event that a soldering iron must be employed the following precautions are recommended.

- Preheat circuit and products to 150°C
- Never contact the ceramic with the iron tip
- Use a 20 watt soldering iron with tip diameter of 1.0mm
- 280° (tip temperature (max))
- 1.0mm tip diameter (max)
- Limit soldering time to 3 sec.



# **6.Packaging Information**

## **Tape Specification:**



Tape Width(mm)	A(mm)	B(mm)	C(mm)	D(mm)	Chip/Reel(pcs)
8	9.0±0.5	60±2	13.5±0.5	178±2	3000



#### 7. Storage and Transportation Information

#### **Storage Conditions**

To maintain the solderability of terminal electrodes:

- 1. Temperature and humidity conditions: -10~ 40°C and 30~70% RH.
- 2. Recommended products should be used within 6 months from the time of delivery.
- 3. The packaging material should be kept where no chlorine or sulfur exists in the air.

#### **Transportation Conditions**

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- Products should be handled with care to avoid damage of contamination from perspiration and skin oils.
- 2. The use of tweezers or vacuum pick up is strongly recommended for individual components.
- 3. Bulk handling should ensure that abrasion and mechanical shock are minimized.